

DYNAMICS OF GLASSES DOPED WITH RARE EARTH IONS: A STUDY BY PERMANENT AND TRANSIENT HOLE-BURNING

P.J. VAN DER ZAAG, B.C. SCHOKKER, Th. SCHMIDT, R.M. MACFARLANE^a
and S. VÖLKER

Center for the Study of the Excited States of Molecules, Huygens and Gorlaeus Laboratories, University of Leiden, Leiden, The Netherlands

^a *IBM Almaden Research Center, San Jose, CA, USA*

The homogeneous linewidths of the electronic transitions $^1D_2 \leftrightarrow ^3H_4$ of Pr^{3+} and $^5D_0 \leftrightarrow ^7F_0$ of Eu^{3+} in silicate glass as a function of temperature have been obtained by means of hole-burning between 0.4 and 12 K, and 0.4 and 3.3 K, respectively. It was found that $\Gamma_{\text{hom}} \propto T^{1.0}$ for both inorganic glassy systems at low temperatures. The influence of the experimental time scale on the holewidth has been studied. No effect was observed for Eu^{3+} between 200 ms and 120 s. While permanent (hours) and short lived holes (minutes to seconds) were observed for Pr^{3+} , only the latter are clearly observed for Eu^{3+} . The hole recovery time was measured as a function of temperature.

1. Introduction

Many optical dephasing studies on organic and inorganic glasses doped with impurities have been reported in the last decade [1]. The aim was to get a better understanding of the dynamics and local structure of amorphous materials. In the first experiment of this sort, performed on Eu^{3+} in silicate glass by means of fluorescence line-narrowing (FLN) between 8 and 90 K, the homogeneous linewidth, Γ_{hom} , was found to be more than an order of magnitude larger than in crystals at low temperatures [2]. Furthermore, Γ_{hom} followed a quadratic temperature dependence which was much weaker than the exponential or T^7 -dependence typical for crystals. From a subsequent hole-burning experiment on the same system at 1.6 K it was concluded that the T^2 -dependence seems to extend down to low temperatures [3].

Other FLN experiments on various rare earth ions in inorganic glasses between ≈ 10 K and 800 K yielded a similar T^2 -dependence of Γ_{hom} [4,5]. Most of the theories developed to interpret these results have been based on a coupling of the optical transition to two-level systems (TLS, or low-frequency modes of the glass) which interact with either phonons or 'fractons' of the bath [6].

In contrast to the large number of dephasing measurements on inorganic glasses at high temperature, very few data exist below 10 K. It has been found that Pr^{3+} in silicate glass follows $\Gamma_{\text{hom}} \propto T^{1.0 \pm 0.2}$ between 1.6 and 20 K. The results were identical when measured by hole-burning and accumulated photon echoes [3]. The other system studied was Nd^{3+} in fused silica in

which two-pulse nanosecond photon echo experiments showed that Γ_{hom} is proportional to $T^{1.3}$ between 0.1 and 1 K [7].

Since hole-burning experiments on many organic glasses and an inorganic porous glass doped with organic molecules yielded a $T^{1.3}$ -dependence of Γ_{hom} between 0.3 K and 20 K [8–11], it is of interest to determine whether such a power law is universally valid for glasses at low temperature, or whether it is restricted to organic guest molecules in amorphous hosts. We have investigated the homogeneous linewidth as a function of temperature for two inorganic amorphous systems, Pr^{3+} and Eu^{3+} in silicate glass, by means of permanent (PHB) and transient (THB) hole-burning between 0.4 and 12 K, and 0.4 and 3.3 K, respectively. We have further studied the influence on the holewidth of the experimental time scale from 120 s down to 200 ms, and have determined the hole recovery rate as a function of temperature.

2. Results and discussion

2.1. Pr^{3+} : silicate glass

The absorption band of the $^1D_2 \leftarrow ^3H_4$ transition of Pr^{3+} (0.1%) in silicate glass at low temperatures extends from ≈ 570 nm to ≈ 610 nm [3]. Its large width is due to an overlap of five crystal-field components, of which only the lowest one decays radiatively. Fast radiationless relaxation occurs from higher crystal-field levels, which is supported by the fact that it was not possible to burn holes at wavelengths smaller than 597.5 nm.

Narrow holes of about 100 MHz width could be burnt between 606.5 nm and 597.5 nm at 1.2 K. In contrast to the results found in ref. [3], the holes did not become broader as the wavelength decreased to 597.5 nm, indicating that the holewidth, Γ_{hole} , is not affected by different local environments. This result was found to be independent of temperature. Furthermore, the holewidths at 606.0 nm were a factor of 2 smaller than previously reported [3], probably due to the order of magnitude lower burning fluences used by us.

Fig. 1 shows the homogeneous linewidth, $\Gamma_{\text{hom}} = \frac{1}{2}\Gamma_{\text{hole}}$ at zero burning fluence, as a function of temperature between 0.4 and 12 K, which follows $\Gamma_{\text{hom}} \propto T^{1.00 \pm 0.02}$. These experiment which have been extended down to 0.4 K here, confirm the linear T -dependence reported in ref. [3]. Notice that when $T \rightarrow 0$ Γ_{hom} extrapolates to zero, which is to be expected on a MHz-scale, since $\Gamma_0 = (2\pi T_1)^{-1}$ is less than a kHz. The measurements were made on a time scale of ~ 100 s. We have not only observed long-lived holes for Pr^{3+} (of about hours) [3] at $T > 1.2$ K, but also short lived holes between 0.4 and 1.2 K which were not previously reported for this system.

The short lived holes burnt in Pr^{3+} : silicate glass have a lifetime τ of about 460 s at 0.4 K, which decreases to ≈ 140 s at 1.2 K (see fig. 2). The value of τ is independent of wavelength. The temperature dependence of τ^{-1} was found to be linear: $\tau^{-1} = (6.0 \pm 0.1) \times 10^{-3} T^{1.0 \pm 0.1}$, between 0.4 and 1.2 K.

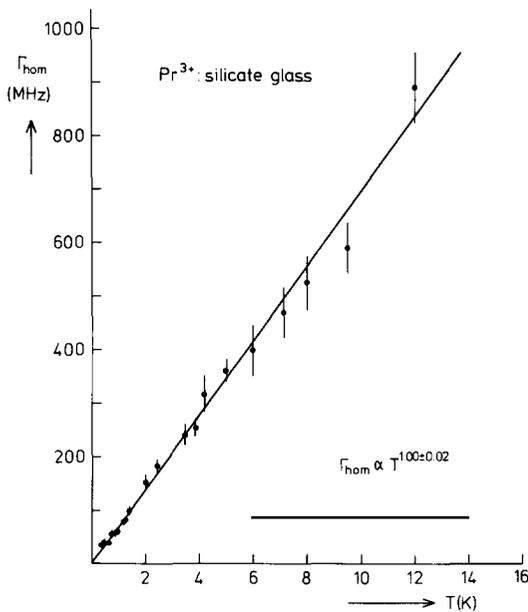


Fig. 1. Temperature dependence of the homogeneous linewidth, Γ_{hom} , of the $^1D_2 \leftarrow ^3H_4$ transition of Pr^{3+} :silicate glass. The holes were burnt at 606.0 nm. Notice that $\Gamma_{\text{hom}} \propto T^{1.00 \pm 0.02}$.

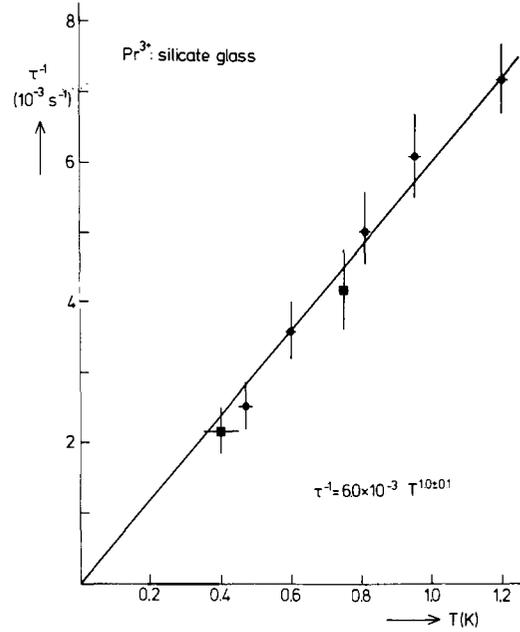


Fig. 2. Inverse of the hole-lifetime, τ^{-1} , as a function of temperature. Holes were burnt at 600.5 nm (circles) and 606.0 nm (squares). The data follow $\tau^{-1} = (6.0 \pm 0.1) \times 10^{-3} T^{1.0 \pm 0.1}$.

2.2. Eu^{3+} : silicate glass

The absorption band of the $^5D_0 \leftarrow ^7F_0$ transition of Eu^{3+} (0.25%) in silicate glass at ≈ 580 nm has a large inhomogeneous width, $\Gamma_{\text{inh}} \approx 100 \text{ cm}^{-1}$, due to a wide range of static environments [4].

In contrast to Pr^{3+} :silicate glass, we have only observed short-lived holes. The mechanism here is assumed to be population redistribution of the nuclear ground state quadrupole levels [3]. The lifetime of a hole for Eu^{3+} is $\tau = 160$ s at 0.75 K.

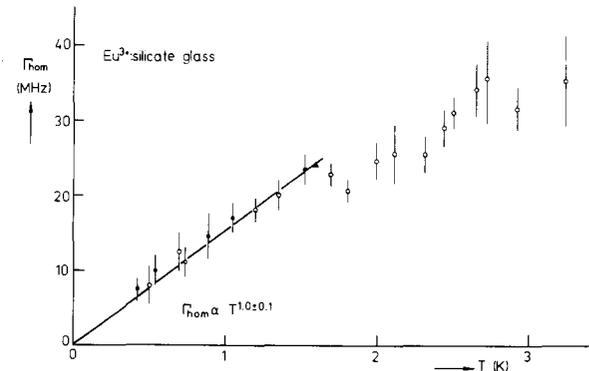


Fig. 3. Temperature dependence of the homogeneous linewidth, Γ_{hom} , of the $^5D_0 \leftarrow ^7F_0$ transition of Eu^{3+} :silicate glass. The holes were burnt at 580 nm. The experimental time scale was > 100 s (closed circles) and < 5 s (open circles). Notice that $\Gamma_{\text{hom}} \propto T^{1.0 \pm 0.1}$ for $T < 1.6$ K.

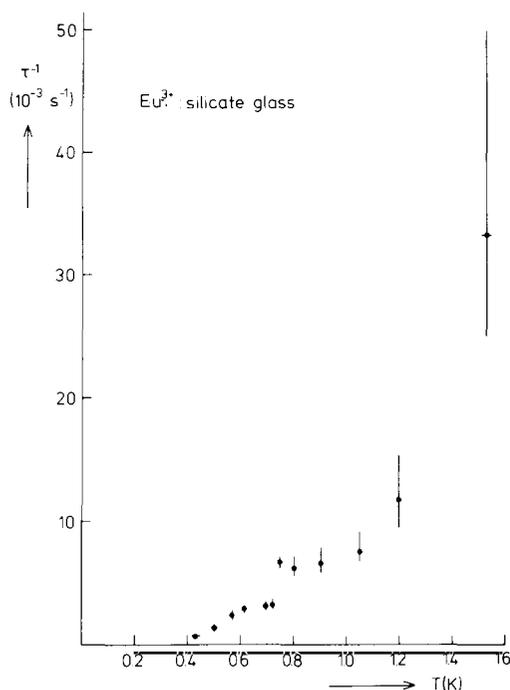


Fig. 4. Inverse of the hole-lifetime (SLR-time), τ^{-1} , as a function of temperature, τ^{-1} is not linearly dependent on T .

The temperature dependence of Γ_{hom} is shown on fig. 3 between 0.4 and 3.3 K. The data follow a linear dependence from 0.4 to 1.6 K and extrapolate to $\Gamma_{\text{hom}} = 0$ MHz for $T \rightarrow 0$. At $T > 1.6$ K, however, the values of Γ_{hom} deviate from this line and bend towards smaller values. We expect a crossover to the previously reported T^2 -dependence at higher temperatures [1,2,12]. If, on the other hand, a line were traced through all the data points from 0.4 up to 3.3 K, a residual linewidth of $\Gamma_0 \approx 5$ MHz would remain which is much larger than the fluorescence-lifetime limited value, $\Gamma_0 = (2\pi T_1)^{-1}$ of less than a kHz.

In fig. 4 the inverse of the hole-lifetime or average spin-lattice relaxation rate, τ^{-1} , as a function of temperature between 0.4 and 1.6 K is plotted. The data do not follow a linear dependence on T . There seems to be a discontinuity in the value of τ^{-1} at (0.74 ± 0.01) K, which invites further investigation.

Finally, we should mention that the holewidths for Eu^{3+} are not influenced by reducing the experimental time scale from 120 s to 200 ms, at 1.2 K. This result is consistent with time-resolved FLN experiments with a spectral resolution of about 1 GHz on Eu^{3+} in inorganic glasses at $T > 10$ K [2,12].

3. Conclusions

We have found that the temperature dependence of the homogeneous linewidth, Γ_{hom} , is linear at low tem-

peratures for both Pr^{3+} ($0.4 \text{ K} < T < 12 \text{ K}$) and Eu^{3+} ($0.4 \text{ K} < T < 1.6 \text{ K}$) in silicate glass. We have not observed a crossover to the expected T^2 -dependence at higher temperatures yet. The $T^{1.0}$ dependence may be explained by some of the theoretical models reported in the literature [2,6], if one assumes a dipole-dipole coupling between the TLS and the rare earth ion, and a constant density of TLS-states. In addition, a direct process involving rapidly relaxing nearby crystal field levels would give a linear T -dependence of Γ_{hom} [13].

Whereas two hole-burning mechanisms (permanent and short-lived) seem to be active for Pr^{3+} , only short-lived holes are dominant for Eu^{3+} in silicate glass [3]. The lifetime of the latter is determined by spin-lattice relaxation (SLR) between nuclear hyperfine levels. The hole recovery rate for Pr^{3+} was found to depend linearly on temperature. The time scale of the experiment does not influence the value of Γ_{hom} for Eu^{3+} in silicate glass between 200 ms and 100 s. Hole-burning experiments on a ms-time scale are in progress.

Acknowledgements

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References

- [1] For a review, see M.J. Weber, ed., *J. Lumin* (Special Issue) 36 (1987) pp. 179–329.
- [2] P.M. Selzer, D.L. Huber, D.S. Hamilton, W.M. Yen and M.J. Weber, *Phys. Rev. Lett.* 36 (1976) 813.
- [3] R.M. Macfarlane and R.M. Shelby, *Opt. Commun.* 45 (1983) 46.
- [4] R.M. Macfarlane and R.M. Shelby, in [1], p. 179 and refs. therein.
- [5] W.M. Yen and R.T. Brundage, in [1], p. 209, and refs. therein.
- [6] R. Silbey and K. Kassner, in [1], p. 283, and refs. therein.
- [7] J. Hegarty, M.M. Broer, B. Golding, J.R. Simpson and J.M. MacChesney, *Phys. Rev. Lett.* 51 (1983) 2033.
- [8] S. Völker, in [1], p. 251, and refs. therein.
- [9] R. Locher, A. Renn and U.P. Wild, *Chem. Phys. Lett.* 138 (1987) 405.
- [10] R. van den Berg, A. Visser and S. Völker, *Chem. Phys. Lett.* 144 (1988) 105.
- [11] S. Völker, in: *Relaxation Processes in Molecular Excited State*, ed., J. Fünfschilling (Kluwer, Deventer, 1989) p. 113; *Ann. Rev. Phys. Chem.* 40 (1989) 499 and refs. therein.
- [12] J.R. Morgan and M.A. El-Sayed, *Chem. Phys. Lett.* 84 (1981) 213.
- [13] R.M. Shelby, *Opt. Lett.* 8 (1983) 88.